

| | | | | |
|-----------------------------------|--|---------------------------------------|---|-------------|
| Notice of References Cited | | Application/Com. No. 09/994,633 | Applicant(s)/Patent Under Reexamination SUNG, MIN-TZU | |
| | | Examiner Jacques Veillard | Art Unit 2175 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-6,542,933 | 04-2003 | Durst et al. | 709/229 |
| | B | US-6,134,532 | 10-2000 | Lazarus et al. | 705/14 |
| | C | US-2002/0120537 | 08-2002 | Morea et al. | 705/35 |
| | D | US-2002/0184102 | 12-2002 | Markopoulos et al. | 705/26 |
| | E | US-2003/0046180 | 03-2003 | Chiu et al. | 705/26 |
| | F | US-6,714,947 | 03-2004 | Fa, Shih-Shan | 707/104.1 |
| | G | US-6,199,048 | 03-2001 | Hudetz et al. | 705/23 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.